

Dependability Analysis of Control Center Networks in Smart Grid Using Stochastic Petri Nets

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Abstract—As an indispensable infrastructure for the future life, smart grid is being implemented to save energy, reduce costs, and increase reliability. In smart grid, control center networks have attracted a great deal of attention, because their security and dependability issues are critical to the entire smart grid. Several studies have been conducted in the field of smart grid security, but few work focuses on the dependability analysis of control center networks. In this paper, we adopt a concise mathematic tool, **stochastic Petri nets (SPNs)**, to analyze the dependability of control center networks in smart grid. We present the general model of control center networks by considering different backup strategies of critical components. With the general SPNs model, we can measure the dependability from two metrics, i.e., the reliability and availability, through analyzing the transient and steady-state probabilities simultaneously. To avoid the state-space explosion problem in computing, the state-space explosion avoidance method is proposed as well. Finally, we study a specific case to demonstrate the feasibility and efficiency of the proposed model in the dependability analysis of control center networks in smart grid.

Index Terms—Smart grid, dependability analysis, stochastic Petri nets.

1 INTRODUCTION

SMART grid introduces modern information technologies, such as the two-way digital communication networks, the automation control technique and smart metering, into the traditional power grid to provide dependable, efficient, and convenient electricity supply services to customers around the entire country. Smart grid can also achieve the characteristics of rapid demand response, self-healing, accommodation of distributed energy generation, etc. Nowadays, many countries invest a great deal of money into the field of smart grid. For instance, US government invests \$3.4 billion in various smart grid related projects in 2009, and the state grid corporation of China plans to invest about 40,000 billion RMB in smart grid before 2020. As expected, smart grid will be widespread implemented around the world in the near future.

Control center networks are to smart grid what brain is to human, and the dependability of control center networks is a significant factor that needs to be seriously considered. For one thing, some critical servers in control center

networks, e.g., supervisory control and data acquisition (SCADA), database, and application server, may suffer from Byzantine failures and various malicious attacks initialized by hackers and terrorists. More catastrophically, a variety of attack tools are available on the Internet for free, making it easy for adversaries to destroy critical components. For another thing, the disruption of control center networks may lead to the power outages or even cascading blackouts, which cost billions of dollars each time [9]. Another disastrous consequence of disruption is loss of customer and public trust. Therefore, control center networks should be designed with high dependability.

Recently, there are several studies on the security of smart grid, especially the control center networks. Ericsson discusses the risks of connecting SCADA systems to the “dangerous” Internet [2]. Fouda et al. present a novel lightweight message authentication scheme using Diffie-Hellman exchange protocol for smart grid [1]. McLaughlin et al. utilize attack tree to discover the potential ways to perform energy theft in smart grid [3]. Ten et al. use attack tree to identify the vulnerabilities of SCADA system in [4], and they perform the same task using another impressive tool, i.e., stochastic Petri nets (SPNs), at system level, scenarios level, and access points level in [5]. The testbeds of SCADA system are implemented to identify vulnerabilities of power infrastructure in [7] and [8]. Bompard et al. present an impressive mathematical framework based on game theory to perform cybersecurity assessment for smart grid [23]. Surveys on these issues can be found in [9] and [22]. In summary, many studies have been conducted in the field of smart grid security, but few work focuses on the dependability evaluation of control center networks, which is also very critical to smart grid.

Dependability analysis, first proposed by Robert Lusser in 1952, evaluates the capability of the target system to

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Manuscript received 16 Sept. 2011; revised 1 Jan. 2012; accepted 24 Jan. 2012; published online 8 Feb. 2012.

Recommended for acceptance by S. Papavassiliou, N. Kato, Y. Liu, C.-Z. Xu, and X. Wang.

For information on obtaining reprints of this article, please send e-mail to: tpdss@computer.org, and reference IEEECS Log Number TPDSSI-2011-09-0651.

Digital Object Identifier no. 10.1109/TPDS.2012.68.

avoid service failures which may cause great losses more than is acceptable [10]. Nowadays, dependability analysis has already been applied to many critical systems, such as national defense systems, aircrafts, and computer networks. In these studies, researchers evaluate the global concept of dependability from the attributes of reliability, availability, safety, performability, maintainability, etc. For the control center networks in smart grid, we also concern with reliability and availability, because control center networks bear no disruptions, and high reliability and availability are two design goals. Thus, dependability analysis is necessary for the control center networks in smart grid.

In this paper, we study the dependability issue of control center networks in smart grid. We use SPNs to model the general control center networks, considering two different backup strategies of critical components, i.e., cold backup and hot backup. Compared with other dependability analysis methods, SPNs are the concise and graphic formalization tools which are universally applied to model distributed, asynchronous, and concurrent systems. Subsequently, we measure the dependability from the metrics of reliability and availability through analyzing the transient and steady-state probabilities at the same time. When the size of target network is large, the state space becomes explosive in computing. To address this issue, we present a state-space explosion avoidance method. Finally, we study a specific case to illustrate the proposed method, which also demonstrates the feasibility and efficiency of the proposed scheme in the dependability analysis of control center networks.

The contributions of this paper are threefold: 1) to the best of our knowledge, this paper is the first work to evaluate the dependability of control center networks in smart grid; 2) we adopt a novel mathematic tool SPNs to analyze two important attributes, i.e., reliability and availability, for control center networks; and 3) through case study, we demonstrate the feasibility and efficiency of the proposed scheme in dependability analysis of control center networks. We also offer some guidelines for designing control center networks with high dependability.

The remainder of this paper is organized as follows. Section 2 surveys the related work, and Section 3 presents the structure of the target control center networks and some preliminaries of SPNs. In Section 4, we propose the general SPNs model of control center networks. Section 5 defines and computes two attributes of dependability, i.e., reliability and availability. We also address the state-space explosion problem in this section. In Section 6, we present the case study to illustrate the dependability analysis method, followed by the conclusions in Section 7.

2 RELATED WORK

Over the past few years, there have been several works in the fields of smart grid security and dependability analysis. In this section, we discuss some of them, which are closely related to our proposed scheme.

2.1 Smart Grid

For the security of smart grid, some results have been published in the recent years. Chen [9] reviews the cyber security and privacy issues in smart grid using NIST

reference architecture, and he also relates these issues to the cyber security in the Internet. Katz [22] gives some thinkings on the security and architecture issues of smart grid. Amin [21] argues that security awareness and personnel training about supervisory control networks are more important than before. Fleury et al. present a novel approach to classify attacks against control center networks into a taxonomy based on attack-vulnerability-damage model in [28]. Fouda et al. propose a light-weight message authentication scheme using Diffie-Hellman exchange protocol for smart grid in [1]. Recently, some methods are presented to identify the vulnerability of smart grid. Ericsson [2] identifies the vulnerabilities of connecting SCADA systems to the Internet. McLaughlin et al. employ attack tree to discover the potential ways to perform energy theft in smart grid [3]. Similarly, Ten et al. use attack tree to identify vulnerabilities of SCADA system in [4], and they also evaluate the same networks using another impressive tool, i.e., SPNs, at system level, scenarios level, and access points level in [5]. Bompard et al. present a mathematical framework based on game theory to perform risk assessment for smart grid [23]. The testbeds of SCADA systems are implemented to identify vulnerabilities of power infrastructure in [7] and [8]. Impressively, Ferrarini et al. perform the dependability evaluation of the protection schemes of power grid using a computer simulator in [29]. Compared with this work, our proposal models a different target, i.e., control center networks, with a distinct mathematical tool SPNs. In summary, few work focuses on the dependability evaluation of control center networks, which is as significant as the vulnerability assessment.

2.2 Dependability Analysis Method

There are two types of quantitative dependability analysis methods: combinatorial models and state-space models. Reliability block diagrams [16], fault tree analysis [17], fault mode effect analysis [27], attack tree [4], attack graph [25], and privilege graph [26] are the main representatives of combinatorial models. The easy construction and explicit presentation make the combinatorial methods a good choice for dependability analysis. However, the limitation of capability to model large and complicated networks make them less competitive than state-space models.

State-space models include Markov chain, Markov reward model [19], Markov regenerative process [18], supplementary variable approach, stochastic Petri nets [5], stochastic process algebra [20], etc. Markov chain is the foundation of various state-space methods in dependability analysis. Markov reward process assigns rewards to the transitions of states in continuous time Markov chain (CTMC), while Markov regenerative process chooses some regenerative points in CTMC or semi-CTMC to simplify the model analysis. Stochastic process algebra [20] uses a process to model the actions of components, making it suitable for modeling resource-sharing systems. As the impressive mathematical tools, SPNs [13] are widely used to the dependability analysis in the recent years. Compared with other dependability analysis methods, SPNs can capture the relationships between actions and states of distributed networks in the simple and concise way, which provides a great advantage over Markov chain and other

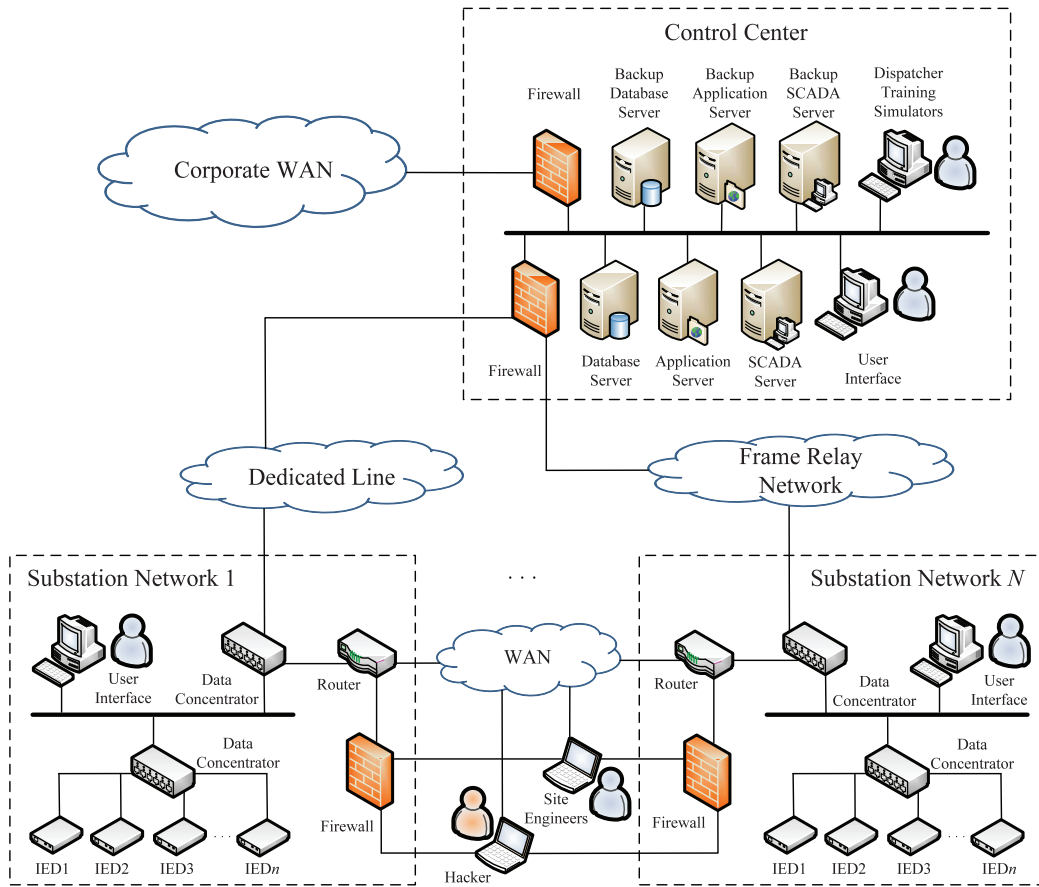


Fig. 1. The system model of control center networks in smart grid.

state-space models. Moreover, various existing results can be applied to SPNs to address the state-space explosion problem faced by all the state-space methods. Thus, we adopt the SPNs model to analyze the dependability of control center networks in smart grid.

3 SYSTEM MODEL AND PRELIMINARY

3.1 System Model

In this paper, we consider the control center networks consisting of one control center and N substation networks, as shown in Fig. 1. In the control center, SCADA servers, database, and application servers are linked with local area networks (LANs), which are protected by the firewalls. If a component in the control center suffers from failure or various attacks, it can be repaired rapidly through user interface. Moreover, backup servers are used to improve the dependability. The control center in one region also connects with control centers in other regions through secure wide area networks (WANs). Since the control center is well protected, we assume that it cannot be intruded from other control centers. However, it can be attacked from the substation networks. N substation networks are connected to the control center through dedicated link or frame relay networks. Substation networks are responsible for collecting data from intelligent electronic devices (IEDs). Site engineers can log into the substation networks to restore failed components. Meanwhile, hackers can also intrude into substation networks if they can succeed in passing the

firewalls. These substations networks are connected with unsecure WAN, thus a substation may be at risk when another substation is compromised.

3.2 Preliminary

3.2.1 Stochastic Petri Nets

Stochastic Petri net is a graphic mathematical tool, which is universally applied to the performance evaluation and dependability analysis of various distributed systems. The definition of SPNs is given as follows.

Definition 1. SPNs can be defined as a five-tuple (P, T, F, M_0, λ) , where

1. $P = \{P_1, P_2, \dots, P_k\}$ is the place set, which describes the states of networks or the conditions for transitions,
2. $T = \{T_1, T_2, \dots, T_l\}$ is the finite set of transitions, the execution of which changes the states of networks,
3. $F = (P \times T) \cup (T \times P)$ is an arc set, connecting places and transitions,
4. $\lambda = \{\lambda_1, \lambda_2, \dots, \lambda_l\}$ is the set of firing rates associated with the transitions. In SPNs, each firing rate λ_i ($i = 1, \dots, l$) is exponentially distributed, and
5. $M_0 = \{M_{01}, M_{02}, \dots, M_{0k}\}$ is an initial marking, which depicts the initial state of networks.

In SPNs models, places, and tokens are separately drawn as circles and black dots, and transitions are denoted by boxes or bars. The transition is enabled when all its input places contain tokens more than the requirements labeled at

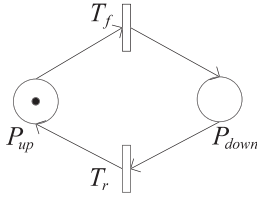


Fig. 2. The failure-repair model of a single component.

the corresponding input arcs. The firing of enabled transition removes tokens from input places to its output places, which modifies the distribution of tokens and generates a new marking for SPNs.

There are some extensions of the basic SPNs, e.g., generalized stochastic Petri nets (GSPNs) [12], stochastic high-level Petri nets [13], and deterministic and stochastic Petri nets. In this paper, we actually use GSPN to model the target control center networks. Compared with the basic SPNs, GSPN classifies transitions into two types: timed transitions (drawn as boxes) and immediate transitions (drawn as bars). The timed transitions have the exponentially distributed service time, as mentioned in Definition 1, while the immediate transitions are promptly fired if the prerequisites are satisfied. In this paper, we use the term SPNs to cover both SPNs and GSPN for simplicity.

4 THE SPNs MODEL FORMULATION

In this section, we first propose the basic failure-repair model of a single server. Then, we study two backup strategies for critical servers and present their SPNs models. Finally, we incorporate the aforementioned models into the general model of the target control center networks.

4.1 The Failure-Repair Model of a Single Server

As a key ingredient of the general model, the failure-repair model of a single component is shown in Fig. 2. Initially, the server is in the operating mode, which is denoted by a token in the place P_{up} . During the operation, the server may suffer from Byzantine failures and various attacks, which leads to the failure of server. The failure state is denoted by the place P_{down} , and the action resulting in this failure is depicted by the transition T_f . When the server fails, it can be repaired by site engineers. The transition T_r of repair operation enables tokens to flow from place P_{down} to place P_{up} . For the transitions T_f and T_r , their firing rates conform to the exponential distribution with parameters λ_f and λ_r , respectively.

In the failure-repair model, we neglect the details of attack and repair and only focus on the impacts of these actions, which is quite different from vulnerability assessment. This feature enables engineers with little knowledge of attacks to perform dependability evaluations.

4.2 The Models of Backup Strategies

In this paper, we consider two backup strategies, i.e., cool backup and hot backup, for critical servers to improve the dependability of control center networks. For the cool backup strategy, only one of the main server and the backup server is used at one time. In other words, the backup server is started only when the main server is failed. In Fig. 3a, we use the transition T_{backup} to denote the event that the backup server is

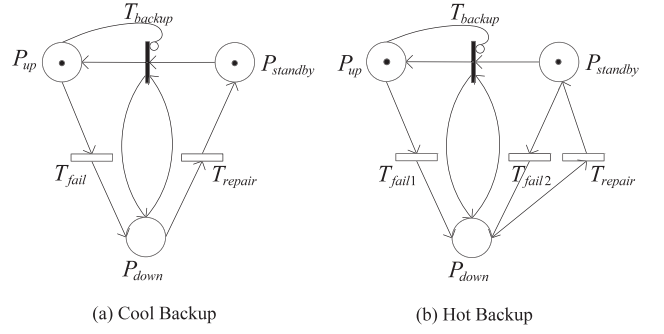


Fig. 3. The models of backup strategies.

started. The prerequisites of T_{backup} are that there is no token in place P_{up} (i.e., the master server is failed) and one token in place $P_{standby}$ (i.e., there is a backup server). For the hot backup strategy, both the main server and backup server work simultaneously, and the backup server is used as a slave server. In terms of the SPNs model, the only difference is that there is an additional transition T_{fail2} between places $P_{standby}$ and P_{down} in the hot backup model, as shown in Fig. 3b.

4.3 The General Model of Control Center Networks

With the above ingredients, we can construct the general SPNs model of dependability for control center networks in Fig. 4. In this model, there are $(N + 1)$ submodels: N submodels of substation networks and 1 submodel of control center. For each substation network, there are two ways for attackers to intrude into the network: destroying the firewall and attacking from other compromised substation networks, which are separately denoted by transitions T_{i-fw-f} and T_{sn-f} . When the substation network i is compromised, meaning that there is a token in the place P_{i-fail} , hackers can launch the following attacks: 1) destroying the data concentrator (DC) or IEDs; 2) intruding other substation networks; and 3) attacking the control center. These attacks are, respectively, denoted by the transitions T_{i-DC-f} , $T_{i-IEDi-f}$, T_{from-i} , and T_{fw-f-i} . If the firewall of control center is disrupted, the state of which is denoted by the place $P_{fw-down}$, then the attacker can further destroy the application servers, SCADA server, or database. Note that two backup strategies are used for critical servers in the general model, as shown in the dotted box.

5 DEPENDABILITY ANALYSIS

In this section, we present the dependability analysis method to evaluate control center networks with the proposed SPNs model. We define two metrics of dependability and provide the detailed method to calculate them. We address the issue of state-space explosion in computing as well.

5.1 Metrics

In this paper, we consider two dependability metrics, i.e., reliability and availability, for control center networks in smart grid. Reliability is used to evaluate the capability to continuously provide services without failures [10]. In detail, it can be defined as the probability that the control center networks work correctly during the period $[0, t]$, i.e.,

$$R(t) = Pr\{X > t\}, \quad (1)$$

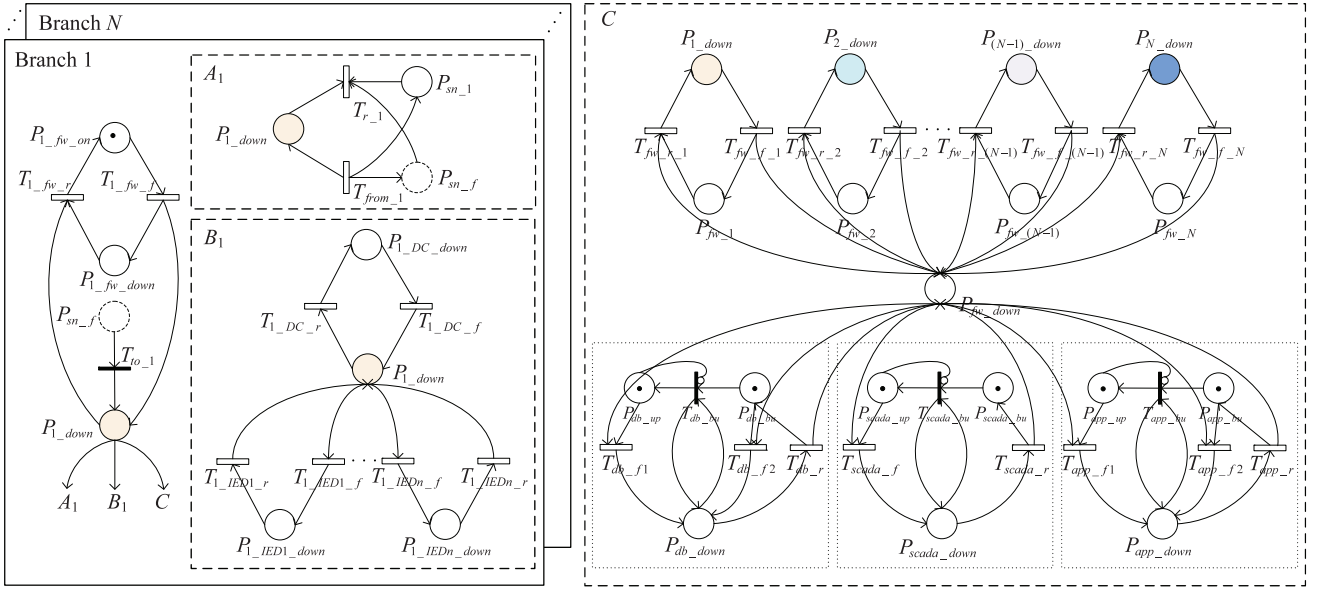


Fig. 4. The general SPNs model of control center networks.

where X is the continuous random variable of correct operation time for control center networks. **Availability describes the readiness of correct services for some critical components** [10]. It can be defined as

$$A(t) = Pr\{\text{Services are available at time } t\}. \quad (2)$$

In the above definitions, both reliability and availability are transient, which means that they focus on the reliability and availability at the time t . In practical, we are also interested in the steady-state dependability. According to the definition of reliability, its steady-state value is zero, i.e.,

$$Rel = \lim_{t \rightarrow \infty} R(t) = 0. \quad (3)$$

The steady-state availability can be defined as

$$Ava = \lim_{t \rightarrow \infty} A(t). \quad (4)$$

5.2 Model Analysis

In this section, we present the calculation method of reliability and availability from both steady-state and transient aspects. The proposed method involves two steps: the analysis of the equivalent **continuous time Markov chain** and the computation of reliability and availability.

Theoretically, Molly has proved that k -bounded SPNs are isomorphic to CTMC due to the memoryless property of the exponentially distributed service time [14]. Then, we could associate SPNs' markings with the CTMC's states to achieve the isomorphism property [24]. In detail, we can obtain the equivalent CTMC by constructing the reachability graph of SPNs and labeling arcs with the sum of the firing rates of transitions whose firings produce the changes of the corresponding states. Note that we delete the vanishing states and only consider tangible states in CTMC.

There are two equivalent methods to compute the steady-state probability of CTMC. In the first approach, which is suitable for calculations on clusters, we have to define the infinitesimal generator $Q = [q_{ij}]$, where $q_{ij} (i \neq j)$ is the transition rate from states M_i to M_j . If there is no arc from

states M_i to M_j , then $q_{ij} = 0$. It should be noted that the element on the diagonal is the negative of the sum of elements in that line, i.e., $q_{ii} = -\sum_{j=1}^{j=n, j \neq i} q_{ij}$. Define the steady-state probability as a vector $\Pi = (\pi_1, \pi_2, \dots, \pi_n)$. Then, we have

$$\begin{cases} \Pi \times Q = 0, \\ \sum_{i=0}^n \pi_i = 1. \end{cases} \quad (5)$$

We can get the steady-state probability by solving these linear equations.

The other method of computing the steady-state probability relies on the birth-death process, which is easy to manually derive analytical solutions. For any marking $M_i \in [M_0 >]$, and all the $M_j, M_k \in [M_0 >]$, $M_i \in [t_j > M_j]$, $M_k \in [t_k > M_i]$, we can have

$$\left(\sum_j \lambda_j \right) \pi_i = \sum_k \lambda_k \pi_k. \quad (6)$$

In addition to the $(n-1)$ equations, we also have $\sum_i \pi_i = 1$. Thus, we can get the vector Π by solving the n equations.

To calculate the transient probability of each state, we define $\pi(t) = [\pi_1(t), \pi_2(t), \dots, \pi_n(t)]$ and have n first order linear differential equations as

$$\frac{d\pi(t)}{dt} = \pi(t)Q. \quad (7)$$

We can get the transient probabilities by solving these differential equations.

Before computing the reliability, we classify all the states into two categories: the states \mathcal{M}_R that the control center networks are reliable and the states $\bar{\mathcal{M}}_R$ that the target networks are not. According to the literature [20], we can have the transient reliability

$$Rel(t) = 1 - Ex \left(\sum_{i=1}^t \lambda_i, t \right) = e^{-\sum_{i=1}^t \lambda_i t}, \quad (8)$$

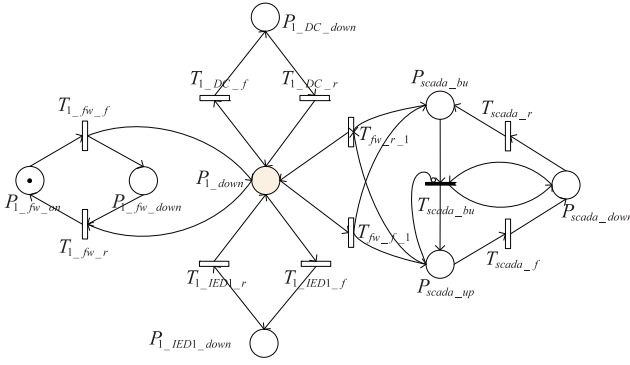


Fig. 5. The SPNs model of the case.

where λ_i is the firing rate of transition whose firing causes the target networks to leave the reliable states. From this definition, we can get that $Rel(\infty) = 0$.

For the availability, we can also have two types of states, i.e., the states \mathcal{M}_A that the target networks are available and the states $\bar{\mathcal{M}}_A$ that the control center networks are not available. Then, the steady-state availability and the transient availability are, respectively,

$$Ava = \sum_i b_i \pi_i, M_i \in \mathcal{M}_A, \quad (9)$$

$$A(t) = \sum_i b_i \pi_i(t), M_i \in \mathcal{M}_A, \quad (10)$$

where b_i is the coefficient.

5.3 The Avoidance of State-Space Explosion

When the size of control center networks increases, the potential states of CTMC will be exponentially increased, which makes it impossible to compute the steady-state probability and transient probability. In this section, we address the state-space explosion problem faced by all the state-space models. In the proposed model, the firing rates of some transitions (e.g., repair transitions $T_{i_fr_r}$, T_{scada_r} , and T_{db_r}) are larger than those of other transitions. From fast transitions point of view, it seems that slow transitions never fire. Based on these observations, we apply the **time scale decomposition (TSD)** method, first proposed by Ammar and Islam [15], to reduce the number of states of CTMC. TSD decomposes the SPNs model into several sublevel models, which only have transitions with the firing rates of the same order of magnitude. The TSD method is detailed as follow:

1. We classify transitions into two types: fast transitions T_f and slow transitions T_s , where $T_s \cup T_f = T$ and $T_s \cap T_f = \emptyset$. Fast transitions include both immediate transitions and fast timed transitions.
2. In the time scale of fast transitions, slow transitions are assumed not to be fired. Then, the SPNs model can be decomposed into several isolated submodels by deleting slow transitions.
3. The submodel k is denoted as place P_k in the aggregated SPNs model. For the transitions in the aggregated SPNs, if there is a transition $t \in T_s$ from any place in the submodel i to any place in the submodel j , then the transition t also exists in the aggregated model to connect places P_i and P_j .
4. The initial marking of the aggregated model is determined by the initial marking of the original SPNs model. In detail, the number of initial tokens in place P_i of the aggregated model equal with the total number of initial tokens in the submodel i . Note that we do not consider tokens that cannot be transferred to other submodels by the firing of transitions in T_s .
5. The firing rate of transition in the aggregated model is the firing rate of corresponding transition in T_s multiplied by the steady-state probability distribution of local marking in the submodel. We can obtain the steady-state probability of local marking by analyzing each submodel in isolation with the current marking of the aggregated model.

6 CASE STUDY AND DISCUSSIONS

In this section, we study the virtual control center networks with one IED ($n = 1$) in one substation ($N = 1$) and only SCADA servers, which are assumed to illustrate the dependability analysis procedure and the state-space explosion avoidance method.

In Fig. 5, we present the SPNs model of this example. The explanations of places and transitions are omitted for the space limitation. We, respectively, set the parameters $\lambda_1, \lambda_2, \dots, \lambda_{10}$ as the firing rates of transitions

$$T_{1_fw_f}, T_{1_fw_r}, T_{1_DC_f}, T_{1_DC_r}, T_{1_IED1_f}, \\ T_{1_IED1_r}, T_{fw_f-1}, T_{fw_r-1}, T_{scada_f},$$

and T_{scada_r} . These parameters can be obtained by analyzing a large volume of statistics and computed as the average of occurrence frequency of events. From this model, we can have the entire markings of SPNs, which can be mapped to the states of CTMC, as shown in Table 1. Then, we can have

TABLE 1
The Markings of the SPNs Model and the States of Corresponding CTMC

	$P_{1_fw_on}$	$P_{1_fw_down}$	P_{1_down}	$P_{1_DC_down}$	$P_{1_IED1_down}$	P_{scada_up}	P_{scada_bu}	P_{scada_down}
M_0	1	0	0	0	0	0	0	0
M_1	0	1	1	0	0	0	0	0
M_2	0	1	0	1	0	0	0	0
M_3	0	1	0	0	1	0	0	0
M_4	0	1	0	0	0	1	1	0
M_5	0	1	0	0	0	1	0	1

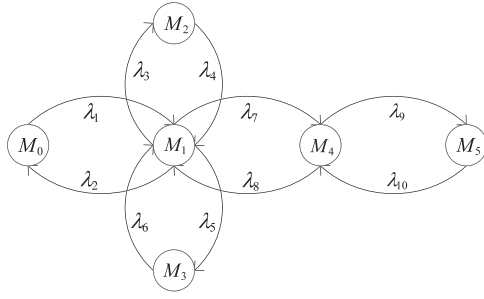


Fig. 6. The equivalent CTMC.

the equivalent CTMC shown in Fig. 6 and its infinitesimal generator Q as

$$Q = \begin{pmatrix} q_{00} & \lambda_1 & 0 & 0 & 0 & 0 \\ \lambda_2 & q_{11} & \lambda_3 & \lambda_5 & \lambda_7 & 0 \\ 0 & \lambda_4 & q_{22} & 0 & 0 & 0 \\ 0 & \lambda_6 & 0 & q_{33} & 0 & 0 \\ 0 & \lambda_8 & 0 & 0 & q_{44} & \lambda_9 \\ 0 & 0 & 0 & 0 & \lambda_{10} & q_{55} \end{pmatrix}, \quad (11)$$

where $q_{ii} = -\sum_{j=0, j \neq i}^5 q_{ij}$ ($i = 0, \dots, 5$). Consequently, we can get the steady-state probability by solving the (5). For the other method, we can base on the birth-death process and have (12) to calculate the steady-state probability.

$$\begin{cases} \lambda_1 \pi_0 = \lambda_2 \pi_1 \\ (\lambda_2 + \lambda_3 + \lambda_5 + \lambda_7) \pi_1 = \lambda_1 \pi_0 + \lambda_4 \pi_2 + \lambda_6 \pi_3 + \lambda_8 \pi_4 \\ \lambda_4 \pi_2 = \lambda_3 \pi_1 \\ \lambda_6 \pi_3 = \lambda_5 \pi_1 \\ (\lambda_8 + \lambda_9) \pi_4 = \lambda_7 \pi_1 + \lambda_{10} \pi_5 \\ \lambda_{10} \pi_5 = \lambda_9 \pi_4 \\ \pi_0 + \pi_1 + \pi_2 + \pi_3 + \pi_4 + \pi_5 = 1 \end{cases} \quad (12)$$

To get the transient reliability and availability at time t , we should compute the transient probability of each state. According to (7), we can have (13). The initial conditions are $\pi_0(0) = 1$, $\pi_1(0) = 0$, $\pi_2(0) = 0$, $\pi_3(0) = 0$, $\pi_4(0) = 0$, and $\pi_5(0) = 0$. The transient probability can be computed by solving these linear differential equations.

$$\begin{cases} \frac{d\pi_0(t)}{dt} = -\lambda_1 \pi_0(t) + \lambda_2 \pi_1(t) \\ \frac{d\pi_1(t)}{dt} = -(\lambda_2 + \lambda_3 + \lambda_5 + \lambda_7) \pi_1(t) + \lambda_1 \pi_0(t) + \lambda_4 \pi_2(t) + \lambda_6 \pi_3(t) + \lambda_8 \pi_4(t) \\ \frac{d\pi_2(t)}{dt} = -\lambda_4 \pi_2(t) + \lambda_3 \pi_1(t) \\ \frac{d\pi_3(t)}{dt} = -\lambda_6 \pi_3(t) + \lambda_5 \pi_1(t) \\ \frac{d\pi_4(t)}{dt} = -(\lambda_8 + \lambda_9) \pi_4(t) + \lambda_7 \pi_1(t) + \lambda_{10} \pi_5(t) \\ \frac{d\pi_5(t)}{dt} = -\lambda_{10} \pi_5(t) + \lambda_9 \pi_4(t) \end{cases} \quad (13)$$

With the steady-state and transient probabilities, we can compute the reliability and availability. For the reliability, it can be seen that only the initial state is reliable, and the rate of leaving the reliable state M_0 is λ_1 . Thus, we can have the transient reliability as

TABLE 2
The Firing Rates of Transitions

λ_1	λ_2	λ_3	λ_4	λ_5
2	100	0.01	0.02	0.01
λ_6	λ_7	λ_8	λ_9	λ_{10}
0.02	2	100	1	200

$$R(t) = e^{-\lambda_1 t}. \quad (14)$$

For the availability of networks, DC, IED, and SCADA server are unavailable in the states M_2 , M_3 , and M_5 , respectively. Then, we can calculate the steady-state and transient availability as

$$Ava = 1 - (a_1 \pi_2 + a_2 \pi_3 + a_3 \pi_5), \quad (15)$$

$$A(t) = 1 - (a_1 \pi_2(t) + a_2 \pi_3(t) + a_3 \pi_5(t)), \quad (16)$$

where a_1, a_2 , and a_3 are, respectively, the weights of DC, IED, and SCADA server.

In Table 2, we present the firing rates of transitions used in the following paper. Note that these parameters are assumed according to the fact that malicious attackers usually need great efforts to destroy the control center networks, while most failures can be promptly repaired by the engineers. We also assume that $a_1 = a_2 = a_3 = 0.3333$. With these settings, we can solve (12) and get the steady-state probability as

$$\begin{aligned} \pi_0 &= 0.9612, & \pi_1 &= 0.0192, \\ \pi_2 &= 9.6117 \times 10^{-3}, & \pi_3 &= 9.6117 \times 10^{-3}, \\ \pi_4 &= 3.8447 \times 10^{-4}, & \pi_5 &= 1.9223 \times 10^{-5}. \end{aligned}$$

According to (15), we can get the steady-state availability as

$$Ava = 0.9936.$$

Similarly, we can obtain the transient probability of each state by solving (13). Considering the space limitations, we omit the detailed analytical solutions and only present the numerical results of the transient probability calculated by the Runge-Kutta method of 4 order in Fig. 7. It can be seen

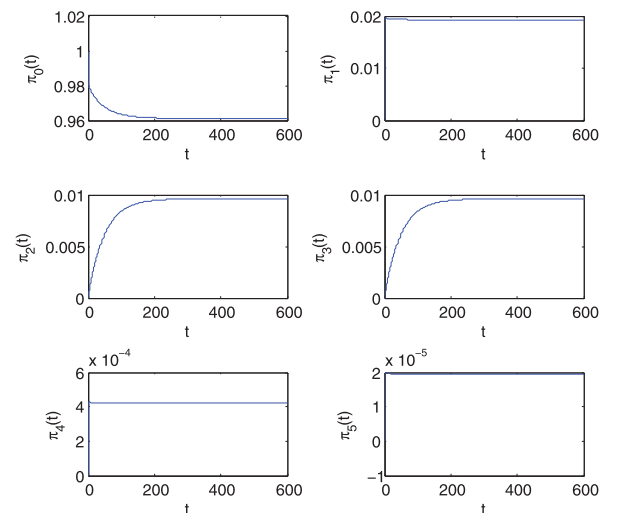


Fig. 7. The transient probability of each state.

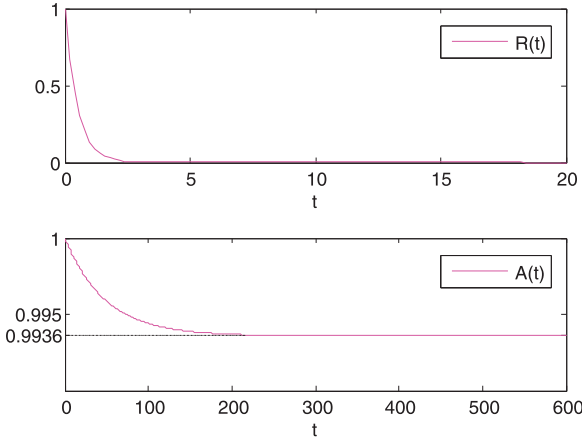


Fig. 8. The transient reliability and availability.

that some transient probabilities (e.g., π_0) are exponentially decreased with time t , while some probabilities (e.g., π_2 and π_3) are exponentially increased with time t . Impressively, each transient probability ultimately approaches to the steady-state probability, which demonstrates the correctness of the proposed analysis method.

In Fig. 8, we present the numerical results of the transient reliability and availability. From this figure, we can see that the transient reliability and availability are exponentially decreased with time t . Moreover, they, respectively, approach to the steady-state reliability $Rel = 0$ and availability $Ava = 0.9936$. Finally, we should mention that the relationship between two reliability values is more important than the accurate values themselves. In other words, the control center networks with large steady-state availability are more dependable and reliable than those with small steady-state availability.

In the following, we employ TSD to reduce the number of states from 6 to 3. Considering the firing rates of transitions, we could classify the transitions into two types: $T_s = \{T_{1_DC_f}, T_{1_DC_r}, T_{1_IED1_f}, T_{1_IED1_r}\}$ and $T_f = \{T_{1_fw_f}, T_{1_fw_r}, T_{fw_f_1}, T_{fw_r_1}, T_{scada_f}, T_{scada_r}\}$. After deleting the slow transitions, the original SPNs are separated into three submodels, as shown in Fig. 9. Each submodel is denoted as a place $P_i (i = 1, 2, 3)$ in the aggregated model. The transitions are selected from the set T_s to

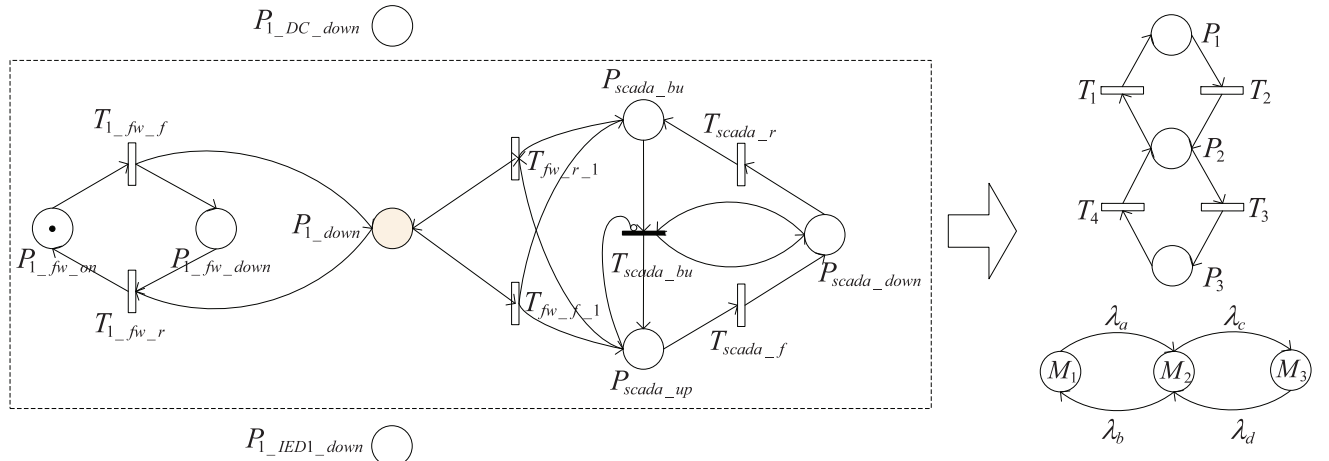


Fig. 9. The aggregated SPNs model.

TABLE 3
The Comparisons of Reliability and Availability with and without TSD Technique

	(a)	(b)	δ
$Rel(t)$	e^{-2t}	e^{-2t}	0
Ava	0.9936	0.9998	0.62%

connect places in the aggregated model. The initial marking in the aggregated model is $M_2 = (0, 1, 0)$. With the initial marking, transitions T_1 and T_3 can be fired. The firing rates of transitions T_1 and T_3 are associated with both the steady-state probability Pr that there is a token in the place P_{1_down} and the firing rates λ_3 and λ_5 , i.e.,

$$\lambda_b = Pr \times \lambda_3,$$

$$\lambda_c = Pr \times \lambda_5.$$

Note that we can apply the proposed analysis method to compute Pr with the submodel in the dashed box of Fig. 9. The firing of transition T_1 generates a new marking $M_1 = (1, 0, 0)$, where only the transition T_2 can be fired. The firing rate of transition T_2 is

$$\lambda_a = \lambda_4.$$

In the marking $M_2 = (0, 1, 0)$, the transition T_3 can be fired, which generates the marking $M_3 = (0, 0, 1)$. In the marking M_3 , only the transition T_4 can be fired, and the firing rate of T_4 is

$$\lambda_d = \lambda_6.$$

Now, we can get the aggregated CTMC, as shown in Fig. 9.

In Table 3, we present the results of reliability and availability, which are computed with the original method (a) and the TSD technique (b). We also present the relative error $\delta = \frac{|x_0 - x|}{x}$, where x computed by the method (a) and x_0 is given by TSD (b), to demonstrate the performance of TSD method. It can be seen that TSD can be applied to address the state-space explosion issue and the error caused by TSD can be neglected. It should also be noted that TSD can

achieve better performance when the firing rates of fast transitions are much larger than those of slow transitions. Refer to [15] for the detailed performance analysis of the TSD technique.

7 CONCLUSIONS

In this paper, we employ SPNs model to study the dependability issue of control center networks in smart grid. We consider two backup strategies for critical components and present the general SPNs model for control center networks. Then, we refine dependability into two specific metrics, i.e., reliability and availability, from both transient and steady-state aspects. We also present the detailed analysis method to calculate these metrics. Moreover, an approach to reduce the state number in computing has been given as well. Finally, we use case study to illustrate our proposed scheme, which also demonstrates the feasibility and correctness of the proposed method. In the future work, we will design a light-weight protection scheme to guarantee the dependability of data transmission in control center networks of smart grid. Moreover, we will study how many states have been reduced by the proposed TSD method and give the analytical solutions of the improvement of the scalability.

ACKNOWLEDGMENTS

This work is supported by the National Grand Fundamental Research 973 Program of China (No. 2010CB328105, No. 2011CB302703, and No. 2009CB320504), the National Natural Science Foundation of China (No. 60932003, No. 61071065, No. 60970101, No. 60872055, No. 61020106002, and No. 60834004), and the National Natural Science Foundation of China A3 Program (No. 61161140320).

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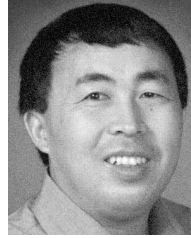
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